UNITED STATES PATENT AND TRADEMARK OFFICE

BEFORE THE PATENT TRIAL AND APPEAL BOARD

MICRON TECHNOLOGY, INC., AND MICRON MEMORY JAPAN, INC., Petitioners

v.

MASSACHUSETTS INSTITUTE OF TECHNOLOGY, Patent Owner

Case: IPR2015-01087 U.S. Patent No. 6,057,221

PETITIONERS' CORRECTED UPDATED EXHIBIT LIST (AS OF DECEMBER 7, 2015)



Pursuant to 37 C.F.R. § 42.63(e) and § 42.64(b)(2), Petitioners Micron Technology, Inc. ("Micron") and Micron Memory Japan, Inc. ("Micron Memory Japan" or "MMJ") (collectively "Petitioners") submit the following corrected and updated Exhibit List identifying the exhibit number and a brief description of each exhibit filed in connection with the above captioned IPR2015-01087.

CORRECTED UPDATED EXHIBIT LIST

| Exhibit # | Exhibit Description |
|-----------|----------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1001 | Declaration of Dr. Michael Thomas |
| 1002 | Curriculum Vitae of Dr. Michael Thomas |
| 1003 | U.S. Patent No. 6,057,221 |
| 1004 | File History for U.S. Patent No. 6,057,221 |
| 1005 | The New IEEE Standard Dictionary of Electrical and Electronic Terms, Fifth Ed., Institute of Electrical and Electronics Engineers, Inc., New York (1993) |
| 1006 | Japan Pat. Appl. Publ. No. 8-213465 to Koyou (including English translation and supporting declaration) |
| 1007 | Japan Pat. Appl. Publ. No. 6-244285 to Wada, et al. (including English translation and supporting declaration) |
| 1008 | U.S. Patent No. 5,729,042 to Lou et al. |
| 1009 | U.S. Patent Application No. 514,800 filed August 14, 1995 (to which U.S. Pat. No. 5,729,042 claims priority) |
| 1010 | U.S. Patent No. 5,025,300 to Billig et al. |
| 1011 | Ex Parte Reexamination Application No. 90/011,607, Request for Ex Parte Reexamination filed March 30, 2011 |



| 1012 | <i>Ex Parte</i> Reexamination Application No. 90/011,607, Corrected Preamendment under 35 C.F.R. 1.530 filed April 14, 2011 |
|------|------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| 1013 | Ex Parte Reexamination Application No. 90/011,607, Order Granting Request for Ex Parte Reexamination filed June 23, 2011 |
| 1014 | Ex Parte Reexamination Application No. 90/011,607, Non-Final Office Action of January 26, 2012 |
| 1015 | Ex Parte Reexamination Application No. 90/011,607, Request for Reconsideration filed March 26, 2012 |
| 1016 | Ex Parte Reexamination Application No. 90/011,607, Declaration of Dr. Bernstein filed March 26, 2012 |
| 1017 | <i>Ex Parte</i> Reexamination Application No. 90/011,607, Notice of Intent to Issue Ex Parte Reexamination Certificate of July 11, 2012 |
| 1018 | "Thermal Conductivity of Metals," The Engineering ToolBox, http://www.engineeringtoolbox.com/thermal-conductivity- metals-d_858.html (last visited April 1, 2015) |
| 1019 | Pierson, Handbook of Refractory Carbides and Nitrides: Properties, Characteristics, Processing, and Applications, Noyes Publications (1996) (excerpt including p. 193) |
| 1020 | U.S. Patent No. 5,872,389 to Nishimura et al. |
| 1021 | U.S. Patent No. 5,675,174 to Nakajima |
| 1022 | U.S. Patent No. 5,538,924 to Chen |
| 1023 | U.S. Patent No. 5,300,461 to Ting |
| 1024 | U.S. Patent No. 5,729,041 to Yoo |
| 1025 | U.S. Patent No. 5,747,869 to Prall |
| 1026 | Wilson et al., Handbook of Multilevel Metallization For Integrated Circuits: Materials, Technology, and Applications, Noyes Publications (1993) |



| 1027 | Wolf, Silicon Processing for the VLSI ERA Volume 2: Process Integration, Lattice Press, Sunset CA (1990) |
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| 1028 | Construction Analyses of the Samsung KM44C4000J-7 16 Megabit DRAM, published by Integrated Circuit Engineering, Scottsdale AZ, Report No. SCA 9311-3001 (available at http://smithsonianchips.si.edu/ice/cd/9311_300.pdf) |
| 1029 | Construction Analyses of the Lattice ispLSI2032-180L CPLD, published by Integrated Circuit Engineering, Scottsdale AZ, Report No. SCA 9712-573 (available at http://smithsonianchips.si.edu/ice/cd/9712_573.pdf) |
| 1030 | Construction Analysis of the Intel Pentium Processor w/MMX, published by Integrated Circuit Engineering, Scottsdale AZ, Report No. SCA 9706-540 (available at http://smithsonianchips.si.edu/ice/cd/9706_540.pdf) |
| 1031 | "Intel Introduces The Pentium® Processor With MMX TM Technology," http://www.intel.com/pressroom/archive/releases/1997/dp010897.htm (last visited April 14, 2015) |
| 1032 | "Intel Microprocessor Quick Reference Guide," http://www.intel.com/pressroom/kits/quickreffam.htm#pentium (last visited April 26, 2015) |
| 1033 | Construction Analyses of the Motorola PC603R Microprocessor, published by Integrated Circuit Engineering, Scottsdale AZ, Report No. SCA 9709-551 (available at http://smithsonianchips.si.edu/ice/cd/9709_551.pdf) |
| 1034 | Construction Analyses of the Toshiba TC5165165AFT-50 64 Mbit DRAM, published by Integrated Circuit Engineering, Scottsdale AZ, Report No. SCA 9702-524 (available at http://smithsonianchips.si.edu/ice/cd/9702_524.pdf) |
| 1035 | "Material: Stainless steel, bulk," https://www.memsnet.org/material/stainlesssteelbulk/ (last visited April 14, 2015) |



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| 1036 | "Material: Silicon Dioxide (SiO2), bulk," https://www.memsnet.org/material/silicondioxidesio2bulk/ (last visited April 14, 2015) |
| 1037 | Osaka, et al. "Development of new electrolytic and electroless gold plating processes for electronics applications," Science and Technology of Advanced Materials, vol. 7 (2006), pp. 425-437. |
| 1038 | Uttecht et al., "A four-level-metal fully planarized interconnect technology for dense high performance logic and SRAM applications," VLSI Multilevel Interconnection Conference, 1991, Proceedings, Eighth International IEEE, June 11-12, 1991, pp. 20-26 |
| 1039 | Ex Parte Reexamination Application No. 90/011,607, Patent Owner Statement filed August 12, 2011 |
| 1040 | Seshan ed., Handbook of Thin-Film Deposition Processes and Techniques: Principles, Methods, Equipment and Applications, Second Ed., Noyes Publications, New York (2002) |
| 1041 | Vlassak, et al., "A new bulge test technique for the determination of Young's modulus and Poisson's ratio of thin films", J. Mater. Res., Vol. 7, No. 12, Dec 1992 |
| 1042 | Ineos USA LLC v. Berry Plastics Corp., No 2014-1540, 2015 WL 1727013, (Fed. Cir. Apr. 16, 2015) (precedential) |
| 1043 | Affidavit of Thomas R. Makin in Support of Motion for <i>Pro Hac Vice</i> Admission |
| 1044 | Affidavit of Rose Cordero Prey in Support of Motion for <i>Pro Hac Vice</i> Admission |
| 1045 | Pierson, Handbook of Refractory Carbides and Nitrides: Properties, Characteristics, Processing, and Applications, Noyes Publications (1996) (excerpt including pp. 181-208) |
| 1046 | Ex Parte Reexamination Application No. 90/011,607, Exhibit B to Declaration of Dr. Bernstein filed March 26, 2012 |
| 1047 | Ex Parte Reexamination Application No. 90/011,607, Exhibit C to Declaration of Dr. Bernstein filed March 26, 2012 |



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